Integration Testing Functional Decomposition Based

Chapter 13

Integration Testing

- Test the interfaces and interactions among separately tested units
- Three different approaches
 - Based on functional decomposition
 - Based on call graphs
 - Based on paths

Functional Decomposition

- Functional Decomposition
 - Create a functional hierarchy for the software
 - Problem is broken up into independent task units, or functions
 - Units can be run either
 - Sequentially and in a synchronous call-reply manner
 - Or simultaneously on different processors
- Used during planning, analysis and design

SATM Units

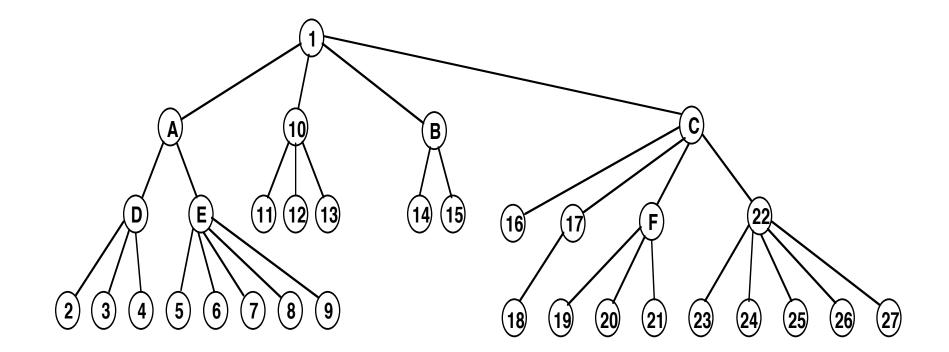
Unit Level Name

- 1 1 SATM system
- A 1.1 Device sense & control
- D 1.1.1 Door sense & control
- 2 1.1.1.1 Get door status
- 3 1.1.1.2 Control door
- 4 1.1.1.3 Dispense cash
- E 1.1.2 Slot sense & control
- 5 1.1.2.1 Watch card slot
- 6 1.1.2.2 Get deposit slot status
- 7 1.1.2.3 Control card Roller
- 8 1.1.2.4 Control Envelope Roller
- 9 1.1.2.5 Read card strip
- 10 1.2 Central bank comm.
- 11 1.2.1 Get PIN for PAN
- 12 1.2.2 Get account status
- 13 1.2.3 Post daily transactions
- B 1.3 Terminal sense & control

Unit Level Name

- 14 1.3.1 Screen door
- 15 1.3.2 Key sensor
- C 1.4 Manage session
- 16 1.4.1 Validate card
- 17 1.4.2 Validate PIN
- 18 1.4.2.1 Get PIN
- F 1.4.3 Close session
- 19 1.4.3.1 New transaction request
- 20 1.4.3.2 Print receipt
- 21 1.4.3.3 Post transaction local
- 22 1.4.4 Manage transaction
- 23 1.4.4.1 Get transaction type
- 24 1.4.4.2 Get account type
- 25 1.4.4.3 Report balance
- 26 1.4.4.4 Process deposit
- 27 1.4.4.5 Process withdrawal

SATM functional decomposition tree Functional Decomposition of the SATM System



- Unit Level Unit Name
- SATM System 1
- **Device Sense & Control** 1.1 A
- D 1.1.1 Door Sense & Control
- 2 1.1.1.1 **Get Door Status**
- 3 1.1.1.2 **Control Door**
- 1.1.1.3 **Dispense Cash** 4
- 1.1.2 Slot Sense & Control Ε 5
 - 1.1.2.1 WatchCardSlot
- 6 1.1.2.2 Get Deposit Slot Status

- Unit Level Unit Nam
 - В 1.3 **Terminal Sense & Control**
 - 14 1.3.1 Screen Driver
 - 15 1.3.2 Key Sensor
 - С 1.4 Manage Session
 - 1.4.1 Validate Card 16
 - 17 1.4.2 Validate PIN

n

- 18 1.4.2.1 GetPIN IntF-5
- F 1.4.3 Close Session
- 19 1.4.3.1 **New Transaction Request**
 - 1100 Drint Doccint



What are the decomposition-based integration strategies?

Decomposition-based integration strategies – 2

- Top-down
- Bottom-up
- Sandwich
- Big bang



• What is the big bang integration process.



- All units are compiled together
- All units are tested together



What are the issues (advantages and drawbacks)?



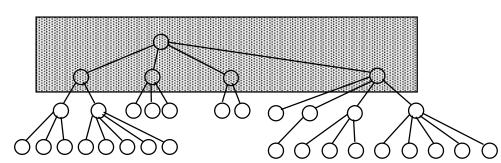
- Failures will occur!
- No clues to isolate location of faults
- No stubs or drivers to write



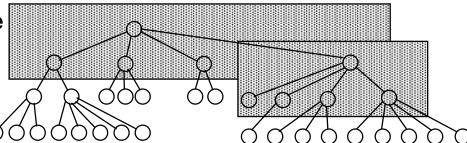
What is the top-down integration process?

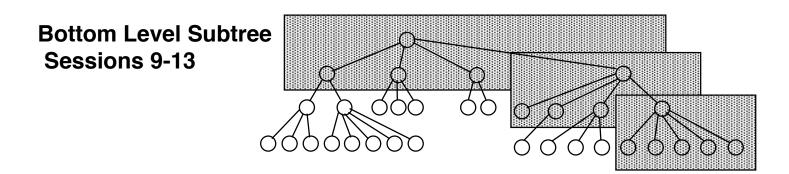
Top-Down integration example

Top Subtree Sessions 1-4



Second Level Subtree Sessions 5-8





Top-Down integration process

- Strategy
 - Focuses on testing the top layer or the controlling subsystem first
 - The main, or the root of the call tree
- General process is
 - To gradually add more subsystems that are referenced/required by the already tested subsystems when testing the application
 - Do this until all subsystems are incorporated into the test

Top-Down integration process – 2

- **Stubs** are needed to do the testing
 - A program or a method that simulates the input-output functionality of a missing subsystem by answering to the decomposition sequence of the calling subsystem and returning back simulated data



What are the issues?

Top-Down integration issues – 2

- Writing stubs can be difficult
 - Especially when parameter passing is complex.
 - Stubs must allow all possible conditions to be tested
- Possibly a very large number of stubs may be required
 - Especially if the lowest level of the system contains many functional units

Top-Down integration issues – 3

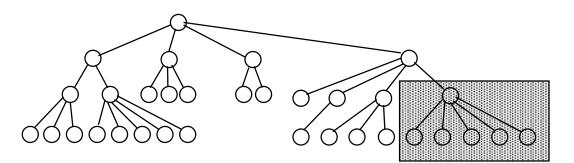
- One solution to avoid too many stubs
 - Modified top-down testing strategy
 - Test each layer of the system decomposition individually before merging the layers
 - Disadvantage of modified top-down testing
 - Both stubs and drivers are needed



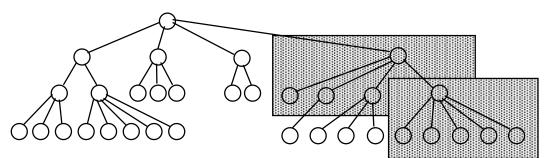
What is the bottom-up integration process?

Bottom-up integration example

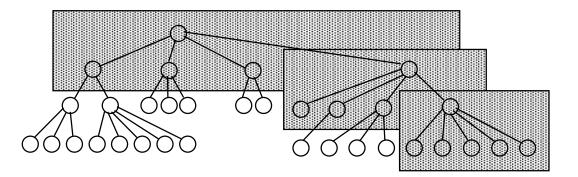
Bottom Level Subtree Sessions 1-5



Second Level Subtree Sessions 6-9



Top Subtree Sessions 10-13



Bottom-Up integration process

- Bottom-Up integration strategy
 - Focuses on testing the units at the lowest levels first
 - Gradually includes the subsystems that reference/require the previously tested subsystems
 - Do until all subsystems are included in the testing



- Drivers are needed to do the testing
 - A driver is a specialized routine that passes test cases to a subsystem
 - Subsystem is not everything below current root module, but a sub-tree down to the leaf level



• What are the issues?

Bottom-Up Integration Issues

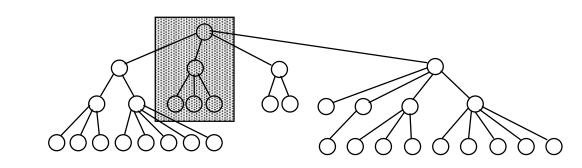
- Not an optimal strategy for functionally decomposed systems
 - Tests the most important subsystem (user interface) last
- More useful for integrating object-oriented systems
- Drivers may be more complicated than stubs
- Less drivers than stubs are typically required

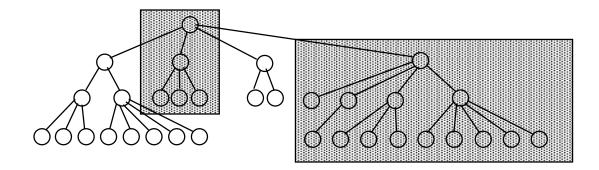


What is the sandwich integration process?

Sandwich integration example

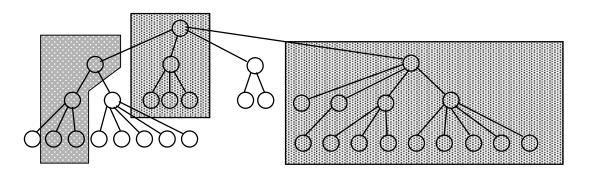
Sandwich 1 Sessions 1-3





Sandwich 2 Sessions 4-13

Sandwich 3 Sessions 14-15





- Combines top-down strategy with bottom-up strategy
 - Doing big bang on a subtree



• What are the issues?



- Less stub and driver development effort
- Added difficulty in fault isolation

Integration test session

- A session is a test suite that tests one edge in the tree
 - Each session tests the combining of two parts
 #sessions = #edges
 - This is different from the textbook

#sessions = #nodes - #leaves + #edges = 2 #edges - #leaves + 1

Alternately

#sessions = #internal_nodes + #edges

Integration work numbers

- For top-down integration
 - #nodes 1 = #edges stubs are needed
- For bottom-up integration
 - #nodes #leaves = #internal_nodes drivers are needed
- The number integrated units for top-down and bottom-up #integrated_units = #internal_nodes

Integration work numbers

- For SATM have 32 integration test sessions
 - Correspond to 32 separate sets of test cases
- For top-down integration
 - 32 stubs are needed
- For bottom-up integration
 - 10 drivers are needed
- For top-down and bottom-up
 - 10 integration units



What is the major drawback of decomposition-based integration?

Decomposition-based drawback – 2

- It is functionally based
 - Has the problems of all functional testing
 - How do we overcome the problems?

Decomposition-based drawback – 3

- It is functionally based
 - Has the problems of all functional testing
 - How do we overcome the problems?
 - Move to structural-based testing